2023 ACM/IEEE International Conference on Technical Debt (TechDebt 2023)

Melbourne, Australia
14-15 May 2023

IEEE

IEEE Catalog Number: CFP23P50-POD
ISBN: 979-8-3503-1195-2

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IEEE Catalog Number:	CFP23P50-POD
ISBN (Print-On-Demand):	979-8-3503-1195-2
ISBN (Online):	979-8-3503-1194-5

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TechDebt 2023

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